Display Elektronik GmbH

DATA SHEET

LCD MODULE

DEM 240064D FGH-PW

Product Specification

Ver.: 1

Version	Revise Date	Page	Content	Modified By
0	16.03.2011	-	First Issue Change Production Line Add Electrical Characteristics	
0.1.0	20.11.2019	-	Change Production Line	
1	15.12.2021		Add Electrical Characteristics	

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1. FEATURES

The features of LCD are as follows

* Display mode : FSTN / Transflective / Positive

* IC : UC1608xGBE

* Interface Input Data : 8 bits/4 bits parallel bus

* Driving Method : 1/64 duty, 1/9 bias

* Viewing Direction : 6 O'clock

* Backlight : 6 LED / side white

* Sample NO : -

2. MECHANICAL SPECIFICATIONS

Item	Specification	Unit
Module Size	126.20 x 55.10 x 5.80	mm
Viewing Area	111.00 x 37.00	mm
Activity Area	105.57 x 31.97	mm
Number of Dots	240 x 64 Dots	-
Dot Size	0.41 x 0.47	mm
Dot Pitch	0.44 x 0.50	mm

3. ELECTRICAL SPECIFICATIONS

3-1 ABSOLUTE MAXIMUM RATINGS (Ta = 25 °C)

Item	Symbol	Sta			
item	Symbol	Min.	Тур.	Max.	Unit
Supply Voltage For Logic	VDD-Vss	-0.3	-	4.0	V
Supply Voltage For LCD Drive	$V_{OP} = V_{DD}-V_0$	-0.3	-	17	V
Input Voltage	Vin	-0.4	-	VDD+0.5	V
Operating Temperature	Тор	-10	-	+60	°C
Storage Temperature	Tst	-20	-	+70	°C

Note: The response time will be extremely slow when the operating temperature is around -10°C, and the back ground will become darker at high temperature operating.

3-2 ELECTICAL CHARACTERISTICS

Item		Symbol	Test Condition	Min.	Тур.	Max.	Unit
Logic Supply	Voltage	VDD-Vss		2.7	3.0	3.3	V
LCD Dri	ve	V _{OP} = V _{DD} -V ₀	Ta = 25°C	11.9	12.1	12.3-	V
Input Voltage	"H" Level	V _{IH}	14 - 25 0	0.8Vpd	-	-	V
	"L" Level	V _{IL}	VDD=3.0V	-	-	0.2VDD	V
Frame Frequency		f _{FLM}		-	75	1	Hz
Current Cons	umption	I _{DD}		-	0.7	-	mΑ

3-3. BACKLIGHT

3-3-1. Absolute Maximum Ratings

Item	Symbol	Condition	Min.	Тур.	Max.	Unit
Forward Current	Ifm		-	-	25*6	mA
Power Dissipation	Pd	Ta = 25 8 C	-	-	75*6	mW
Reverse Voltage	Vr		-	-	5	V

3-3-2. Electrical-optical Characteristics

Item	Symbol	Condition	Mi	in.	Ту	η.	Ma	ax.	Unit
Forward Voltage	Vf		2.	2.9 3.1		3	.3	V	
Luminance	Lv			50		-		-	cd/m ²
LED Lifetime	-	Ta = 25 8 C If = 90mA	20,	000	30,	000		•	hour
			Х	Υ	Χ	Υ	Χ	Υ	
Colour Coordinates	-		0.25	0.25	0.28	0.28	0.32	0.32	-

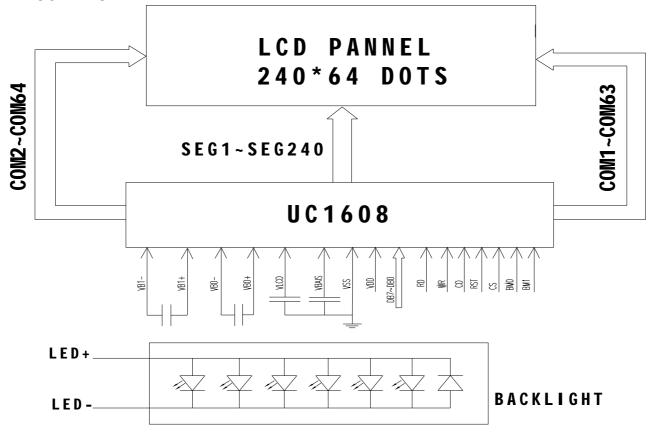
Note: The brightness is measured without LCD panel. For operation above 258C, The Ifm Ifp & Pd must be derated, the current derating is -0.36mA/8C for DC drive and -0.86 mA/8C for Pulse drive, the Power dissipation is -1.5mW/8C. The produt working current must not more than the 60% of the Ifm or Ifp according to the working temperature.

4. TERMINAL FUNCTIONS AND BLOCK DIAGRAM

4-1. INTERFACE PIN FUNCTION DESCRIPTION

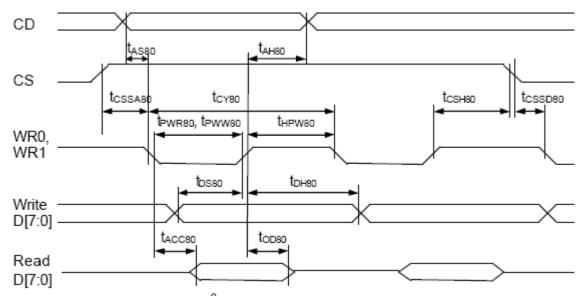
Pin No.	Pin Name	Function
1	NC	Not connect pin
2~5	VB1-,VB1+,VB0-,VB0+	LCD bias voltage
6	VLCD	LCD Power Supply
7	VBIAS	This is the reference voltage to generate the actual seg driving voltage
8	VSS	Ground
9	VDD	VDD is digital VDD
10~17	DB7~DB0	Command/data selection Data bus
18	RD	Read operation
19	WR	Write operation
20	CD	Control date/data selection
21	RST	Reset signal
22	CS	Chip selection
23~24	BM0,BM1	Bus mode selection

4-2. BLOCK DIAGRAM



5. TIMING CHARACTERISTICS

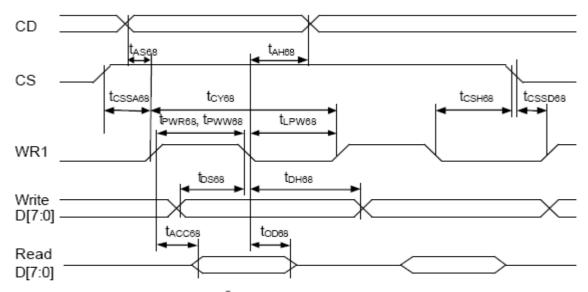
Parallel Bus Timing Characteristics (for 8080 MCU)



 $(2.7V \le V_{DD} < 3.3V, Ta = -30 \text{ to } +85^{\circ}C)$

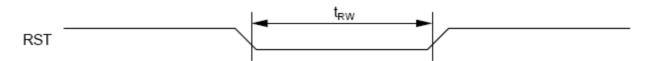
Symbol	Signal	Description	n	Condition	Min.	Max.	Units
taseo	CD	Address setup time			0	_	nS
tah80		Address hold time			20		
t _{CY80}		System cycle time				_	nS
		8 bits bus	(read)		140		
			(write)		140		
		4 bits bus	(read)		140		
			(write)		140		
t _{PWR80}	WR1	Pulse width	8 bits (read)		65	-	nS
			4 bits		65		
t _{PWW80}	WR0	Pulse width	8 bits (write)		35	_	nS
			4 bits		35		
t _{HPW80}	WR0, WR1	High pulse width				-	nS
		8 bits bus	(read)		65		
			(write)		35		
		4 bits bus	(read)		65		
			(write)		35		
t _{DS80}	D0~D7	Data setup time			30	-	nS
t _{DH80}		Data hold time			20		
t _{ACC80}		Read access time		C _L = 100pF	_	60	nS
topso		Output disable time			12	20	
tssa80	CS1/CS0	Chip select setup tin	ne		10		nS
t _{CSSD80}					10		
tcsнао					20		

Parallel Bus Timing Characteristics (for 6800 MCU)



 $(2.7V \le V_{DD} < 3.3V, Ta = -30 \text{ to } +85^{\circ}C)$

Symbol	Signal	Description	Condition	Min.	Max.	Units
tases tahes	CD	Address setup time Address hold time		0 20	-	nS
Тсүөв		System cycle time 8 bits bus (read) (write) 4 bits bus (read) (write)		140 140 140 140	-	nS
t _{PWR68}	WR1	Pulse width 8 bits (read) 4 bits		65 65	_	nS
t _{PWW68}		Pulse width 8 bits (write) 4 bits		35 35	_	nS
t _{LPWe8}		Low pulse width 8 bits bus (read) (write) 4 bits bus (read) (write)		65 35 65 35	-	nS
toses t _{ohes}	D0~D7	Data setup time Data hold time		30 20	_	nS
tacces topes		Read access time Output disable time	C _L = 100pF	- 12	60 20	nS
tcssa68 tcssb68 tcsh68	CS1/CS0	Chip select setup time		10 10 20		nS



 $(2.7V \le V_{DD} < 3.3V, Ta = -30 \text{ to } +85^{\circ}C)$

Symbol	Signal	Description	Condition	Min.	Max.	Units
t _{RW}	RST	Reset low pulse width		1000	_	nS

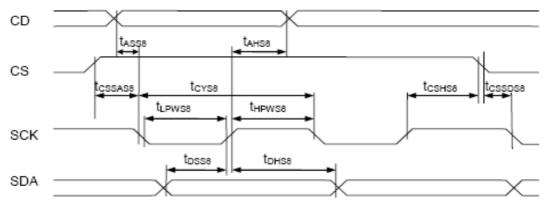


FIGURE 17: Serial Bus Timing Characteristics (for S8)

 $(2.7V \le V_{DD} < 3.3V, Ta = -30 \text{ to } +85^{\circ}C)$

Symbol	Signal	Description	Condition	Min.	Max.	Units
tassa	CD	Address setup time		0	-	nS
t _{AHS8}	CD	Address hold time		20	-	nS
tcyss		System cycle time		140	_	nS
t _{LPWS8}	SCK	Low pulse width		65	-	nS
t _{HPWS8}		High pulse width		65	_	nS
t _{ossa} t _{onsa}	SDA	Data setup time Data hold time		30 20	-	nS
tcssass tcssdss tcshss	cs	Chip select setup time		10 20 10		nS

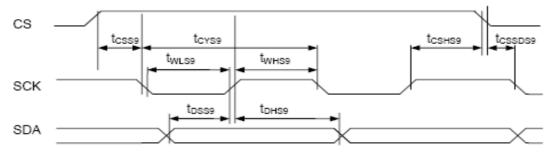


FIGURE 18: Serial Bus Timing Characteristics (for S9)

 $(2.7V \le V_{DD} \le 3.3V$, Ta= -30 to +85°C)

Symbol	Signal	Description	Condition	Min.	Max.	Units
t _{CYS9}		System cycle time		140	_	nS
t _{LPWS9}	SCK	Low pulse width		65	-	nS
t _{HPWS9}		High pulse width		65	_	nS
tosse tonse	SDA	Data setup time Data hold time		30 20	-	nS
t _{CSSAS9} t _{CSSDS9} t _{CSHS9}	CS	Chip select setup time		10 20 10		nS

6. INSTRUCTION SET

The following is a list of host commands supported by UC1608

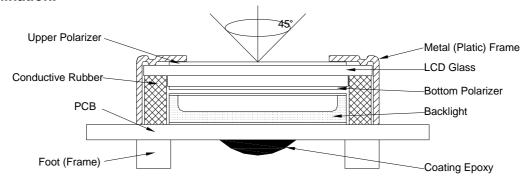
C/D: 0: Control, 1: Data W/R: 0: Write Cycle, 1: Read Cycle

Useful Data bits
- Don't Care

	Command	C/D	W/R	D7	D6	D5	D4	D3	D2	D1	D0	Action	Default
1	Write Data Byte	1	0	#	#	#	#	#	#	#	#	Write 1 byte	N/A
2	Read Data Byte	1	1	#	#	#	#	#	#	#	#	Read 1 byte	N/A
3	Get Status	0	1	ΒZ	MX	DE	RS	WA	GN1	GN0	1	Get Status	N/A
4	Set Column Address LSB	0	0	0	0	0	0	#	#	#	#	Set CA[3:0]	0
7	Set Column Address MSB	0	0	0	0	0	1	#	#	#	#	Set CA[7:4]	0
5	Set Mux Rate and temperature compensation.	0	0	0	0	1	0	0	#	#	#	Set {MR, TC[1:0]}	MR: 1b TC: 00b
6	Set Power Control	0	0	0	0	1	0	1	#	#	#	Set PC[2:0]	101b
7	Set Adv. Program Control.	0	0	0	0	1	1	0	0	0	R	For UltraChip only.	N/A
<i>'</i>	(double byte command)	0	0	#	#	#	#	#	#	#	#	Do not use.	IN/A
8	Set Start Line	0	0	0	1	#	#	#	#	#	#	Set SL[5:0]	0
9	Set Gain and Potentiometer	0	0	1	0	0	0	0	0	0	1	Set {GN[1:0],	GN=3
Ŭ	(double-byte command)	0	0	#	#	#	#	#	#	#	#	PM[5:0]}	PM=0
10	Set RAM Address Control	0	0	1	0	0	0	1	#	#	#	Set AC[2:0]	001b
11	Set All-Pixel-ON	0	0	1	0	1	0	0	1	0	#	Set DC[1]	0=disable
12	Set Inverse Display	0	0	1	0	1	0	0	1	1	#	Set DC[0]	0=disable
13	Set Display Enable	0	0	1	0	1	0	1	1	1	#	Set DC[2]	0=disable
14	Set Fixed Lines	0	0	1	0	0	1	#	#	#	#	Set FL[3:0]	0
15	Set Page Address	0	0	1	0	1	1	#	#	#	#	Set PA[3:0]	0
16	Set LCD Mapping Control	0	0	1	1	0	0	#	#	#	#	Set LC[3:0]	0
17	System Reset	0	0	1	1	1	0	0	0	1	0	System Reset	N/A
18	NOP	0	0	1	1	1	0	0	0	1	1	No operation	N/A
19	Set LCD Bias Ratio	0	0	1	1	1	0	1	0	#	#	Set BR[1:0]	10b=12
20	Reset Cursor Mode	0	0	1	1	1	0	1	1	1	0	AC[3]=0, CA=CR	N/A
21	Set Cursor Mode	0	0	1	1	1	0	1	1	1	1	AC[3]=1, CR=CA	N/A
22	Set Test Control	0	0	1	1	1	0	0	1	Т	Τ	For UltraChip only.	N/A
~~	(double byte command)	0	0	#	#	#	#	#	#	#	#	Do not use.	IN/A

7. QUALITY SPECIFICATIONS

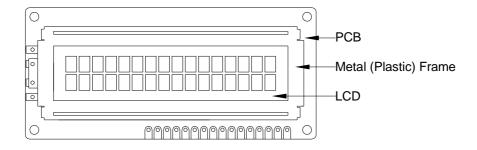
- 7 1. LCM Appearance and Electric inspection Condition
 - 1. Inspection will be done by placing LCM 30cm away from inspector's eyeballs under normal illumination.



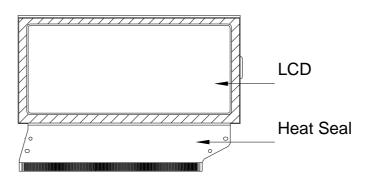
2. View Angle: with in 45° around perpendicular line.

7 - 2. Definition

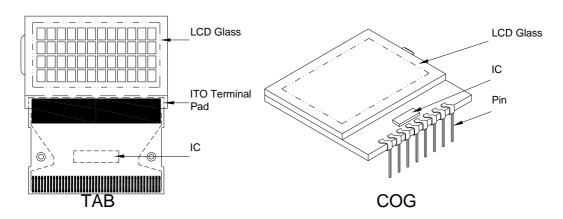
1. COB



2. Heat Seal



3. TAB and COG



7-3. Sampling Plan and Acceptance

1.Sampling Plan

MIL - STD - 105E (\square) ordinary single inspection is used.

2.Acceptance

Major defect: AQL = 0.65%Minor defect: AQL = 1.5%

7-4. Criteria

1.COB

Defect	Inspection Item	Inspection Standards				
Major	PCB copper flakes peeling off	Any copper flake in viewing Area should be greater than 1.0mm ²	Reject			
Major	Height of coating epoxy	Exceed the dimension of drawing	Reject			
Major	Void or hole of coating epoxy	Expose bonding wire or IC	Reject			
Major	PCB cutting defect	Exceed the dimension of drawing	Reject			

2.SMT

<u> 2. SMT </u>			
Defect	Inspection Item	Inspection Standa	ards
Minor	Component marking not readable		Reject
Minor	Component height	Exceed the dimension Of drawing	Reject
Major	Component solder defect (missing, extra, wrong component or wrong orientation		Reject
Minor	Component position shift component soldering pad X D Y Y Y	X < 3/4Z Y > 1/3D	Reject Reject
Minor	Component tilt component soldering pad	Y > 1/3D	Reject
Minor	Insufficient solder component PAD PCB	θ <u><</u> 20°	Reject

3. Metal (Plastic) Frame

Defect	Inspection Item	Inspection Standards				
Major	Crack / breakage	Any	Reject			
		W	L	Acceptable of Scratch		
		w<0.1mm	Any	Ignore		
		0.1 <u><</u> w<0.2mm	L <u><</u> 5.0mm	2		
Minor	Frame Scratch	0.2 <u><</u> w<0.3mm	L <u><</u> 3.0mm	1		
		w <u>></u> 0.3mm	Any	0		
		Note: 1. Above criteria applicable to scratch lines with distance greater than 5mm. 2. Scratch on the back side of frame (not visible) can be ignored.				
				Acceptable of Dents / Pricks		
		Φ <u><</u>	2			
	Frame Dent , Prick	1.0<	1			
Minor	$\Phi = \frac{L + W}{2}$	1.5	0			
		Note: 1. Above criteria applicable to any two dents / pricks with distance greater than 5mm 2. Dent / prick on the back side of frame (no visible) can be ignored				
Minor	Frame Deformation	Excee	d the dimension of	drawing		
Minor	Metal Frame Oxidation		Any rust			

4. Flexible Film Connector (FFC)

Defect	Inspection Item	Inspection Standards				
Minor	Tilted soldering	Within the angle +5°	Acceptable			
Minor	Uneven solder joint /bump		Reject			
		Expose the conductive line	Reject			
Minor	Hole $\Phi = \frac{L + W}{2}$	Φ > 1.0mm	Reject			
Minor	Position shift	Y > 1/3D	Reject			
IVIIIIOI		X > 1/2Z	Reject			

5. Screw

<u>0. 00.011</u>				
Defect	Inspection Item	Inspection Standards		
Major	Screw missing/loosen		Reject	
Minor	Screw oxidation	Any rust	Reject	
Minor	Screw deformation	Difficult to accept screw driver	Reject	

6. Heatseal, TCP, FPC

Defect	Inspection Item	Inspection Standards	
Major	Scratch expose conductive layer		Reject
Minor	HS Hole $\Phi = \frac{L + W}{2}$	Φ> 0.5mm	Reject
Major	Adhesion strength	Less than the specification	Reject
Minor	Position shift	Y > 1/3D	Reject
IVIII IOI		X > 1/2Z	Reject
Major	Conductive line break		Reject

7. LED Backing Protective Film and Others

Defect	Inspection Item	Inspection Standards					
		Acceptable number of units					
		Φ <u><</u> 0.10mm	Ignore				
	371	0.10<Φ <u><</u> 0.15mm	2				
Minor		0.15<Φ <u><</u> 0.2mm	1				
		Ф>0.2mm	0				
		The distance between any two spots should be > Any spot/dot/void outside of viewing area is accept					
Minor	Protective film tilt	Not fully cover LCD	Reject				
Major	COG coating	Not fully cover ITO circuit	Reject				

8. Electric Inspection

Defect	Inspection Item	Inspection Standards	
Major	Short		Reject
Major	Open		Reject

DEM 240064D FGH-PW
9. Inspection Specification of LCD

Defect	ection Specific	Inspection Standards								
	- 1	* Glass Scratch	W	W <u><</u> 0.03					V>0.05	
		* Polarizer Scratch	L		 L<5			L<3		Any
Minor	Linear Defect	* Fiber and Linear	ACC. NO.			1		1		Reject
		material	Note	L is th	e ler	ngth and W	/ is th	e width of	the de	fect
		* Foreign material	-	Φ <u><</u> 0).1	0.1<Φ <u><</u> 0	.15	0.15<Φ <u><</u> 0.	2	Ф>0.2
. A.	Black Spot and	i. –		3E <i>A</i> 100m		2		1		0
Minor	Polarizer Pricked	and glass * Polarizer hole or protuberance by external force	Note	Φ is the average diameter of the defect. Distance between two defects > 10mm.						
		* Unobvious	Φ		Φ <u><</u> (0.3	0.3	<Φ <u><</u> 0.5	0.	5<Ф
	White Spot	transparant foreign material between		3EA	A / 10	00mm²		1		0
Minor	and Bubble in polarizer	glass and glass or glass and polarizer * Air protuberance between polarizer and glass	Note			verage diameter of the defect. letween two defects > 10mm.				
	Segment Defect			Φ <u><</u> 0.10 0.10<Φ <u><</u>		<0.20 0.20<Φ<0.25		Ф>0.25		
				3EA / 100mm ² 2		1			0	
Minor		, w, ,		Note $\Phi = \frac{L + W}{2}$ Distance between two defect is 10mm				Reject		
		W.	Note							
			Ф	Φ <u><</u> 0.	.10	0.10<Φ <u><</u>	0.20	0.20<Φ <u><</u>	0.25	Ф>0.25
Minor	Protuberant	w V	W	Glu	Glue W≤1/2 W≤0.					Ignore
IVIIIIOI	Segment	$\Phi = (L + W)/2$	ACC. NO.	3EA 100m				1		0
			1. Seg	ment						
			Е	3	B <u><</u>	0.4mm	0.4 <e< td=""><td>3<u><</u>1.0mm</td><td>B>1</td><td>.0mm</td></e<>	3 <u><</u> 1.0mm	B>1	.0mm
Minor	Assembly		B-			A<1/2B		A<0.2		<0.25
IVIII IOI	Mis-alignment	H _B -1 -1 H _A	Judge Acceptable Acceptable Acceptable					eptable		
			2. Dot Matrix Deformation>2° Reje					Reject		
Minor	Stain on LCD Panel Surface		Deformation>2° R Accept when stains can be wiped lightly with a soft or a similar one. Otherwise, judged according t above items: "Black spot" and "White Spot"				soft cloth			

8. RELIABILITY

No	Item	Condition	Quantity	Criteria	
1	High Temperature Operating	60°C, 96Hrs	2	GB/T2423.2 -2008	
2	Low Temperature Operating	-10°C, 96Hrs	2	GB/T2423.1 -2008	
3	High Humidity	60°C, 90%RH, 96Hrs	2	GB/T2423.3 -2016	
4	High Temperature Storage	70°C, 96Hrs	2	GB/T2423.2 -2008	
5	Low Temperature Storage	-20°C, 96Hrs	2	GB/T2423.1 -2008	
6	Thermal Cycling Test	-10°C, 60min~60°C, 60min, 20 cycles.	2	GB/T2423.22 -2012	
7	Packing vibration	Frequency range:10Hz~50Hz Acceleration of gravity:5G X,Y,Z 30 min for each direction.	2	GB/T5170.14 -2009	
8	Electrical Static Discharge	Air:±8kV 150pF/330Ω 5 times	2	GB/T17626.2	
	Lieutical Static Discharge	Contact:±4kV 150pF/330Ω 5 times	2	-2018	
9	Drop Test(Packaged)	Height:80 cm,1 corner, 3 edges, 6 surfaces.	2	GB/T2423.8 -1995	

Note:1) Above conditions are suitable for standard products.

²⁾ For restrict products, the test conditions listed as above must be revised.

9. HANDLING PRECAUTION

(1) Mounting Method

The panel of the LCD Module consists of two thin glass plates with polarizers which easily get damaged since the Module is fixed by utilizing fitting holes in the printed circuit board. Extreme care should be taken when handling the LCD Modules.

(2) Caution of LCD handling & cleaning

When cleaning the display surface, use soft cloth with solvent (recommended below) and wipe lightly.

- Isopropyl alcohol
- Ethyl alcohol
- Trichloro thane

Do not wipe the display surface with dry or hard materials that will damage the polarizer surface.

Do not use the following solvent:

- Water
- Ketone
- Aromatics

(3) Caution against static charge

The LCD Module use C-MOS LSI drivers, so we recommend that you connect any unused input terminal to VDD or VSS, do not input any signals before power is turned on. And ground your body, Work/assembly table. And assembly equipment to protect against static electricity.

(4) Packaging

- Modules use LCD elements, and must be treated as such. Avoid intense shock and falls from a height.
- To prevent modules from degradation. Do not operate or store them exposed directly to sunshine or high temperature/humidity.

(5) Caution for operation

- It is indispensable to drive LCD's within the specified voltage limit since the higher voltage than the limit shorten LCD life. An electrochemical reaction due to direct current causes LCD deterioration, Avoid the use of direct current drive.
- Response time will be extremely delayed at lower temperature than the operating temperature range and on the other hand at higher temperature LCD's show dark color in them. However those phenomena do not mean malfunction or out of order with LCD's. Which will come back in the specified operating temperature range.
- If the display area is pushed hard during operation, some font will be abnormally displayed but it resumes normal condition after turning off once.
- A slight dew depositing on terminals is a cause for electro-chemical reaction resulting in terminal open circuit.

Usage under the relative condition of 40°C, 50%RH or less is required.

(6) Storage

In the case of storing for a long period of time (for instance.) For years) for the purpose or replacement use, The following ways are recommended.

- Storage in a polyethylene bag with sealed so as not to enter fresh air outside in it, And with no desiccant.
- Placing in a dark place where neither exposure to direct sunlight nor light is. Keeping temperature in the specified storage temperature range.
- Storing with no touch on polarizer surface by the anything else. (It is recommended to store them as they have been contained in the inner container at the time of delivery)

(7) Safety

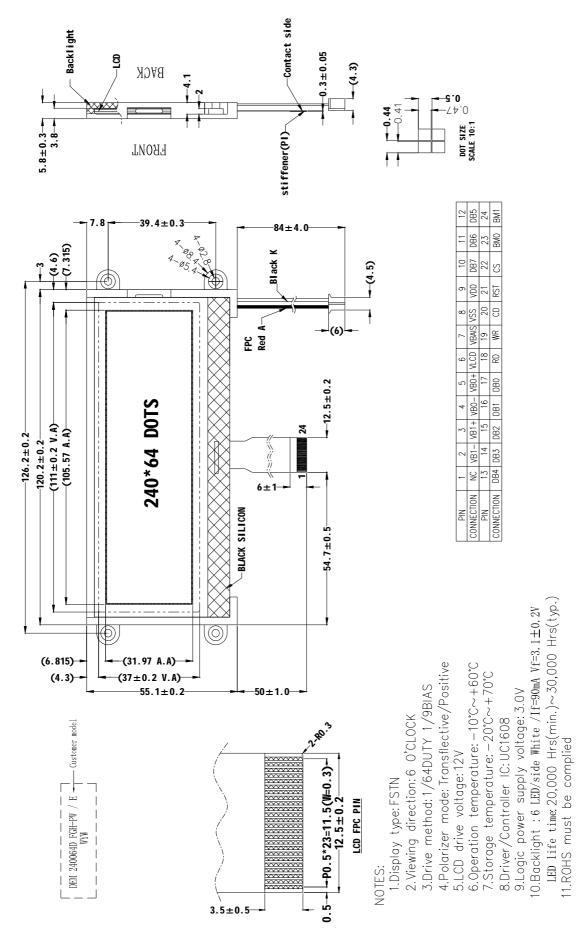
- It is recommendable to crash damaged or unnecessary LCD into pieces and wash off liquid crystal by using solvents such as acetone and ethanol. Which should be burned up later.

When any liquid crystal leaked out of a damaged glass cell comes in contact with your hands, please wash it off well with soap and water.

(8) Limited Warranty

- Our warranty liability is limited to repair and/or replacement. We will not be responsible for any consequential loss.
- If possible, we suggest customer to use up all modules in six months. If the module storage time over twelve months, we suggest that recheck it before the module be used
- After the product shipped, any product quality issues must be feedback within three months, otherwise, we will not be responsible for the subsequent or consequential events.

10. OUTLINE DIMENSION



Note: The dimension with"()" is reference.